2SD1199

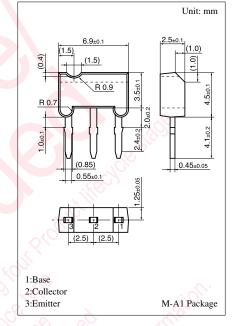
Silicon NPN epitaxial planer type

For low-frequency amplification

Features

- High foward current transfer ratio h_{FE}.
- Low collector to emitter saturation voltage V_{CE(sat)}.
- High emitter to base voltage V_{EBO} .
- Low noise voltage NV.
- M type package allowing easy automatic and manual insertion as well as stand-alone fixing to the printed circuit board.

Absolute Maximum Ratings (Ta=25°C)							
Parameter	Symbol	Ratings	Unit				
Collector to base voltage	V _{CBO}	50	V				
Collector to emitter voltage	V _{CEO}	40	V				
Emitter to base voltage	V _{EBO}	15	v				
Peak collector current	I _{CP}	100	mA				
Collector current	I _C	50	mA				
Collector power dissipation	P _C	400	mW				
Junction temperature	Tj	150	°C				
Storage temperature	T _{stg}	-55 ~ +150	°C				



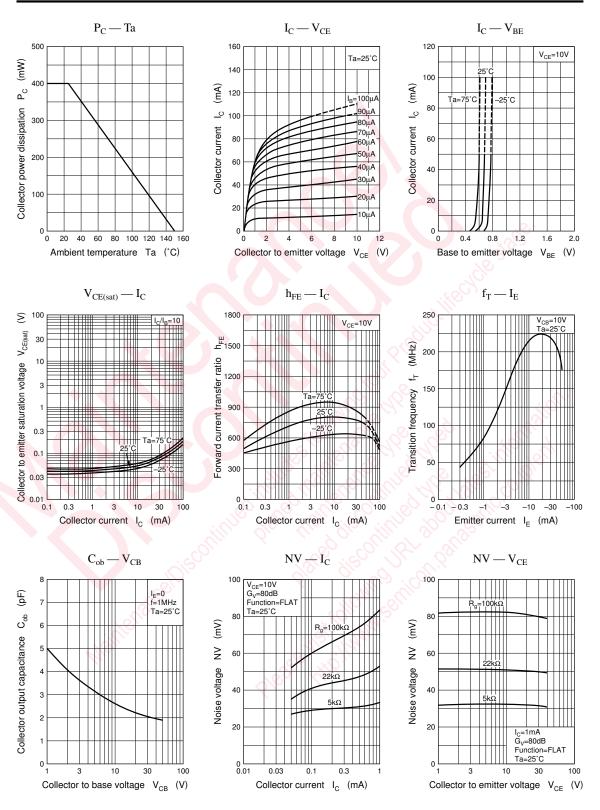
Electrical Characteristics (Ta=25°C)

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector cutoff current	I _{CBO}	$V_{CB} = 20V, I_E = 0$	06		100	nA
	I _{CEO}	$V_{CE} = 20V, I_B = 0$	2.		1	μΑ
Collector to base voltage	V _{CBO}	$I_{\rm C} = 10\mu A, I_{\rm E} = 0$	50			V
Collector to emitter voltage	V _{CEO}	$I_{\rm C} = 1 {\rm mA}, I_{\rm B} = 0$	40			V
Emitter to base voltage	V _{EBO}	$I_{\rm E} = 10 \mu A, I_{\rm C} = 0$	15			V
Forward current transfer ratio	h _{FE} *	$V_{CE} = 10V, I_{C} = 2mA$	400		2000	
Collector to emitter saturation voltage	V _{CE(sat)}	$I_{C} = 10mA, I_{B} = 1mA$		0.05	0.2	V
Transition frequency	f _T	$V_{CB} = 10V, I_E = -2mA, f = 200MHz$		120		MHz
Noise voltage	NV	$V_{CE} = 10V, I_C = 1mA, G_V = 80dB$ $R_g = 100k\Omega$, Function = FLAT		80		mV

*hFE Rank classification

Rank	R	S	Т
h _{FE}	400 ~ 800	600 ~ 1200	1000 ~ 2000

Transistor



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